

UTC UNISONIC TECHNOLOGIES CO., LTD

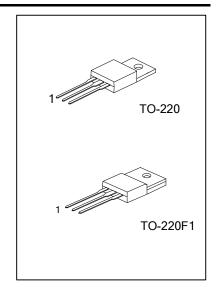
9N40 **Preliminary Power MOSFET**

9A, 400V N-CHANNEL **POWER MOSFET**

DESCRIPTION

The UTC 9N40 is an N-channel mode power MOSFET using UTC's advanced technology to provide customers with planar stripe and DMOS technology. This technology specializes in allowing a minimum on-state resistance and superior switching performance. It also can withstand high energy pulse in the avalanche and commutation mode.

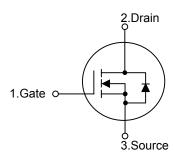
The UTC 9N40 is universally applied in electronic lamp ballast based on half bridge topology and high efficient switched mode power supply.



FEATURES

- * High switching speed
- * $R_{DS(ON)}$ =0.54 Ω @ V_{GS} =10V
- * 100% avalanche tested

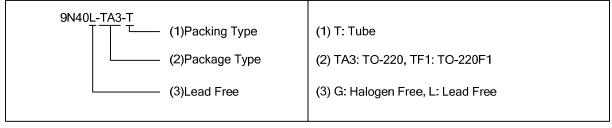
SYMBOL



ORDERING INFORMATION

Ordering Number		Doolsono	Pin	Doolsing			
Lead Free	Halogen Free	Package	1	2	3	Packing	
9N40L-TA3-T	9N40G-TA3-T	TO-220	G	D	S	Tube	
9N40L-TF1-T	9N40G-TF1-T	TO-220F1	G	D	S	Tube	

Note: Pin Assignment: G: Gate D: Drain S: Source



■ **ABSOLUTE MAXIMUM RATINGS** (T_C=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltag	е	V_{DSS}	400	V
Gate-Source Voltage	in Current Continuous (T _C =25°C) Pulsed (Note 2)		±30	V
Avalanche Energy R	Continuous (T _C =25°C)	I_{D}	9	Α
	Pulsed (Note 2)	I _{DM}	36	Α
Avalanche Current (I	valanche Current (Note 2)		VDSS 400 V VGSS ±30 V TC=25°C) ID 9 A 2) IDM 36 A IAR 9 A A I (Note 3) EAS 427 mJ ote 2) EAR 4.0 mJ 4) dv/dt 4.5 V/ns 220 113 W 220F1 PD 0.9 W/°C	
A	Single Pulsed (Note 3)	E _{AS}	427	400 V ±30 V 9 A 36 A 9 A 427 mJ 4.0 mJ 4.5 V/ns 113 W
Avaianche Energy	Repetitive (Note 2)	VGSS ±30 V J=25°C) ID 9 A J IDM 36 A J IAR 9 A Note 3) EAS 427 mJ E 2) EAR 4.0 mJ dv/dt 4.5 V/ns 20 113 W 20F1 40 W 20F1 0.9 W/°C 20F1 0.32 W/°C		
Peak Diode Recover	ry dv/dt (Note 4)			
Drain-Source Voltage Gate-Source Voltage Drain Current Avalanche Current (Note 2 Avalanche Energy Peak Diode Recovery dv/ Power Dissipation Derate above 25°C Junction Temperature	TO-220		113	W
Power Dissipation	TO-220F1	_	40	W
Power Dissipation TO-220 113 40 TO-220 0 9	W/°C			
Derate above 25°C		W/°C		
Junction Temperature		TJ	+150	°C
Storage Temperature		T _{STG}	-55~+150	°C

- Note: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.
 - 2. Repetitive Rating: Pulse width limited by maximum junction temperature
 - 3. L = 10.5mH, I_{AS} = 9A, V_{DD} = 90V, R_{G} = 25 Ω , Starting T_{J} = 25 $^{\circ}$ C
 - 4. $I_{SD} \le 9A$, di/dt $\le 200A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25^{\circ}C$

■ THERMAL DATA

PARAMETER		SYMBOL	RATINGS	UNIT
Junction to Ambient		θ_{JA}	62.5	°C/W
horation to Oace	TO-220	θυς	1.1	90/14/
Junction to Case	TO-220F1		3.125	°C/W

■ **ELECTRICAL CHARACTERISTICS** (T_C=25°C, unless otherwise noted)

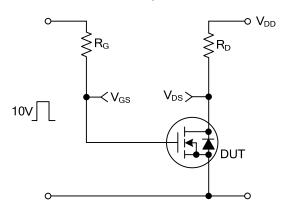
PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage		BV_{DSS}	$I_D = 250 \mu A, V_{GS} = 0 V$	400			V
Drain-Source Leakage Current		I _{DSS}	V _{DS} =400V, V _{GS} =0V			1	μΑ
Cata Course Leakage Current	Forward	,	V_{GS} =+30V, V_{DS} =0V			+100	nA
Gate- Source Leakage Current	Reverse	I _{GSS}	V_{GS} =-30V, V_{DS} =0V			-100	nA
ON CHARACTERISTICS							
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$	2.0		4.0	V
Static Drain-Source On-State Res	sistance	R _{DS(ON)}	V_{GS} =10V, I_D =4.5A		0.6	0.75	Ω
DYNAMIC PARAMETERS							
Input Capacitance		C_{ISS}			1340		pF
Output Capacitance		Coss	V _{GS} =0V, V _{DS} =25V, f=1.0MHz		160		pF
Reverse Transfer Capacitance		C_{RSS}			490		pF
SWITCHING PARAMETERS							
Total Gate Charge		Q_G	\\ -10\\ \\ -220\\ I =0A		34		nC
Gate to Source Charge Gate to Drain Charge		Q_GS	V _{GS} =10V, V _{DS} =320V, I _D =9A (Note 1, 2)		18		nC
		Q_GD	(Note 1, 2)		16		nC
Turn-ON Delay Time		$t_{D(ON)}$	V_{DD} =200V, I_{D} =9A, R_{G} =25 Ω		22		ns
Rise Time		t_R			60		ns
Turn-OFF Delay Time		$t_{D(OFF)}$	(Note 1, 2)		32		ns
Fall-Time		t_{F}	7		140		ns
SOURCE- DRAIN DIODE RATIN	IGS AND CI	HARACTERIST	TICS				
Maximum Body-Diode Continuou	s Current	I _S				9	Α
Maximum Body-Diode Pulsed Current		I _{SM}				36	Α
Drain-Source Diode Forward Voltage		V_{SD}	I _S =9A, V _{GS} =0V			1.7	V
Body Diode Reverse Recovery T	ime	t_{RR}	I_S =9A, V_{GS} =0V, dI_F/dt =100A/ μ s		350		ns
Body Diode Reverse Recovery C	harge	Q_{RR}	(Note 1)		2.6		μC

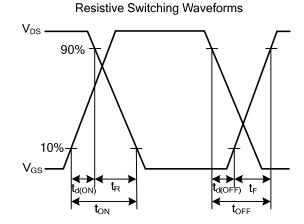
Notes: 1. Pulse Test: Pulse width ≤ 300µs, Duty cycle ≤ 2%

^{2.} Essentially independent of operating temperature

■ TEST CIRCUITS AND WAVEFORMS

Resistive Switching Test Circuit





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